Appendix I Datasheet of BAP 72 – 02



1 Product profile

1.1 General description

Planar PIN diode in a SOD523 ultra small SMD plastic package.

1.2 Features and benefits

- High voltage; current controlled RF resistor for attenuators
- · Low diode capacitance
- · Very low series inductance
- · AEC-Q101 qualified

1.3 Applications

- RF attenuators
- (SAT) TV
- · Car radio

2 Pinning information

Table 1. Discrete pinning

Pin	Description	Simplified outline	Symbol
1	cathode		14
2	anode	1 2	sym006

3 Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BAP70-02	-	plastic surface-mounted package; 2 leads	SOD523



Silicon PIN diode

4 Marking

Table 3. Marking

Type number	Marking code
BAP70-02	K8 ^[1]

^[1] The marking bar indicates the cathode (see simplified outline graphic in <u>Table 1</u>)

5 Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_R	reverse voltage	continuous voltage	-	50	V
IF	forward current	continuous current	-	100	mA
P _{tot}	total power dissipation	T _{sp} ≤ 90 °C	-	415	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-65	+150	°C

6 Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point		145	K/W

7 Characteristics

Table 6. Characteristics

 T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
V _F	forward voltage	I _F = 50 mA	-	0.9	1.1	V	
I _R	reverse current	V _R = 50 V	-	-	100	nA	
C _d	diode capacitance	f = 1 MHz (see <u>Figure 1</u>)					
		V _R = 0 V	-	570	-	fF	
		V _R = 1 V	-	400	-	fF	
	V _R = 5 V	-	270	-	fF		
		V _R = 20 V	-	200	250	fF	

Silicon PIN diode

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
r _D	diode forward resistance	f = 100 MHz (see Figure 2)				Ω Ω Ω Ω
		I _F = 0.5 mA	-	77	100	Ω
		I _F = 1 mA	-	40	50	Ω
		I _F = 10 mA	-	5.4	7	Ω
		I _F = 100 mA	-	1.4	1.9	Ω
τι	charge carrier life time	when switched from I_F = 10 mA to I_R = 6 mA; R_L = 100 Ω ; measured at I_R = 3 mA	-	1.25	-	μs
L _S	series inductance	I _F = 100 mA; f = 100 MHz	-	0.6	-	nH

8 Graphical data

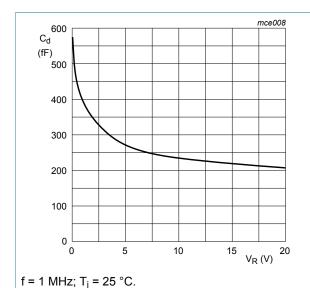
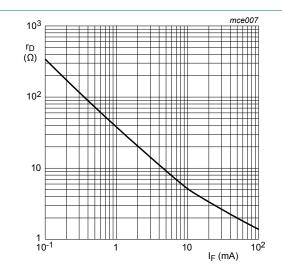


Figure 1. Diode capacitance as a function of reverse voltage (typical values)

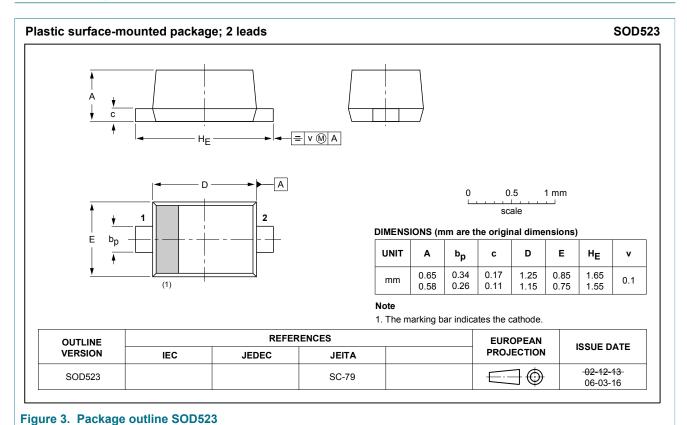


f = 100 MHz; $T_i = 25 ^{\circ}\text{C}$.

Figure 2. Diode forward resistance as a function of forward current (typical values)

Silicon PIN diode

9 Package outline



10 Abbreviations

Table 7. Abbreviations

Acronym	Description
PIN	P-type, Intrinsic, N-type
SMD	Surface-Mounted Device
RF	Radio Frequency

Silicon PIN diode

11 Revision history

Table 8. Revision history

Table 6. Revision history			T	
Document ID	Release date	Data sheet status	Change notice	Supersedes
BAP70-02 v.8	20181211	Product data sheet	-	BAP70-02 v.7
Modifications:		tures and benefits" has been u nation" pages have been updat		
BAP70-02 v.7	20140416	Product data sheet	-	BAP70-02 v.6
BAP70-02 v.6	20140211	Product data sheet	-	BAP70-02_N v.5
BAP70-02_N v.5	20080102	Product data sheet	-	BAP70-02_N v.4
BAP70-02_N v.4	20070322	Product data sheet	-	BAP70-02 v.3
BAP70-02 v.3 (9397 750 10093)	20020806	Product data sheet	-	BAP70-02_N v.2
BAP70-02_N v.2 (9397 750 10079)	20020702	Preliminary data sheet	-	BAP70-02_N v.1
BAP70-02_N v.1 (9397 750 09578)	20020402	Preliminary data sheet	-	-
		1		

Silicon PIN diode

12 Legal information

12.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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BAP70-02

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Silicon PIN diode

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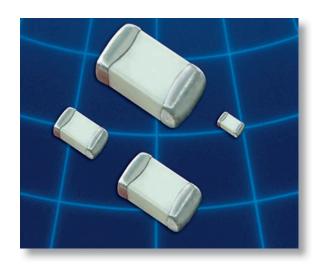
Contents

Product profile	1
Features and benefits	
Applications	1
Limiting values	2
Thermal characteristics	2
Characteristics	2
	General description Features and benefits

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

Appendix II Datasheet of 0603 Capacitor

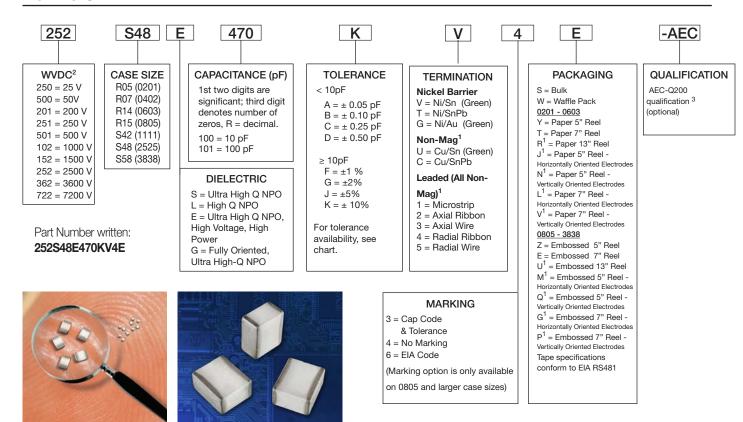
Multi-Layer High-Q Capacitors



These lines of multilayer capacitors have been developed for High-Q and microwave applications.

- The **S-Series** (R07S, R14S, R15S) capacitors give an ultrahigh Q performance, and exhibit NP0 temperature characteristics.
- The **L-Series** (R05L) capacitors give mid-high Q performance, and exhibit NP0 temperature characteristics.
- The **E-Series** (S42E, S48E, S58E) capacitors give excellent high-Q performance from HF to Microwave frequencies. Typical uses are high voltage, high current applications. They are offered in chip (Ni barrier or Non-Magnetic Pt.-Ag) or in Non-Magnetic leaded form.
- RoHS compliance is standard for all unleaded parts (see termination options box).
- Automotive versions (AEC-Q200) of R05L, R07S, R14S, R15S, and S42E series are available on request

How to Order



- ¹ Not available for all MLCC Call factory for info.
- ² WVDC Working Voltage DC.
- ³ -Qualification required for automotive application, Not available for all series Call factory for info.



Low ESR / High-Q Capacitor Selection Chart

	EIA Size						RF Power Applications							
Cap. Value		SIZE	0201	(R05)	0402	0603	0805	0805	11	11	2525	38	38	
			NPO (R05L)	NPO (R05G)	(R07S)	(R14S)	(R15S)	(R15L)	(S42E)		(S48E)	48E) (S58E)		
Capac pF	citance Code													
0.1	0R1													
0.2	0R2		25/50 V	25 V	50/250 V	250 V			500V	1500V				
0.3	0R3		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V				
0.4	0R4		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V				
0.5	0R5		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V			
0.6	0R6		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
0.7	0R7		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
0.8	0R8		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
0.9	0R9		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.0	1R0		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.1	1R1		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.2	1R2	A	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.3	1R3	_	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.4	1R4	В	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.5	1R5	_	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.6	1R6	С	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.7	1R7		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.8	1R8		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
1.9	1R9	D	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
2.0	2R0		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
2.1	2R1	-	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
2.2	2R2 2R4	-	25/50 V 25/50 V	25 V 25 V	50/250 V 50/250 V	250 V 250 V	250 V 250 V		500V 500V	1500V 1500V	3600V 3600V	3600V 3600V	7200V 7200V	
2.4	2R7	-	25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
3.0	3R0		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
3.3	3R3		25/50 V	25 V	50/250 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
3.6	3R6	-	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
3.9	3R9	-	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
4.3	4R3	-	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
4.7	4R7	-	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
5.1	5R1		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
5.6	5R6	A**	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
6.2	6R2	В	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
6.8	6R8	D	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
7.5	7R5	С	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
8.2	8R2	D	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
9.1	9R1		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
10	100		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
11	110		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
12	120	Г	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
13	130	F	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
15	150		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
16	160	G	25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
18	180		25/50 V	25 V	50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
20	200	J K	25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
22	220		25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
24	240		25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
27	270	- 1 \	25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
30	300		25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	
33	330		25/50 V		50/200 V	250 V	250 V		500V	1500V	3600V	3600V	7200V	

Consult factory for Non-Standard values.
**A tolerance only available for R07S (0402) and R14S(0603) caps



Low ESR / High-Q Capacitor Selection Chart

EIA Size						RF Power Applications							
	EIA	Size	0201	(R05)	0402	0603 0805 0805		0805	11	11	2525	38	38
Cap. V	alue		NPO (R05L)	NP0 (R05G)	(R07S)	(R14S)	(R15S)	(R15L)	(\$4	2E)	(S48E)	(S5	8 E)
Capac		Toler- ance											
pF 36	Code 360	ance	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
39	390	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
43	430	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
47	470	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
51	510	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
56	560	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
62	620	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
68	680	-	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
75	750		25/50 V		-	250 V	250 V		500V	1500V	3600V	3600V	7200
													_
82 91	820	⊣ F ∣	25/50 V		-	250 V	250 V		500V	1500V	3600V	3600V	7200
	910	_	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
100	101	\dashv G \dashv	25/50 V			250 V	250 V		500V	1500V	3600V	3600V	7200
110	111	_					250 V		300V	1500V	2500V	3600V	7200
120	121	J					250 V		300V	1000V	2500V	3600V	7200
130	131	J					250 V		300V	1000V	2500V	3600V	7200
150	151						250 V		300V	1000V	2500V	3600V	7200
160	161	K					250 V		300V	1000V	2500V	3600V	7200
180	181						250 V		300V	1000V	2500V	3600V	7200
200	201						250 V		300V	1000V	2500V	3600V	
220	221						250 V		200V	1000V	2500V	3600V	
240	241							500V	200V	600V	2500V	3600V	
270	271							500V	200V	600V	2500V	3600V	
300	301							500V	200V	600V	1500V	3600V	
330	331							500V	200V	600V	1500V	3600V	
360	361							500V	200V	600V	1500V	3600V	
390	391							500V	200V	500V	1500V	3600V	
430	431							500V	200V	500V	1500V	2500V	
470	471							500V	200V	500V	1500V	2500V	
510	511							100V	200V	500V	1000V	2500V	
560	561							100V	200V	500V	1000V	2500V	
620	621							100V	200V	500V	1000V	2500V	
680	681							50V	200V		1000V	2500V	
750	751							50V	200V		1000V	2500V	
820	821							50V	200V		1000V	2500V	
910	911	G						50V	200V		1000V	1000V	
1000	102							50V	200V		1000V	1000V	
1200	122	- J						50V	200		1000V	1000V	
1500	152				<u> </u>			50V		 	500V	1000V	
1800	182	K						50V			500V	1000V	
2200	222				-			50V		-	300V	1000V	\vdash
2700	272							30V			300V	500V	
					-					-	3007		-
3300	332											500V	-
3900	392									-		500V	\vdash
4700	472									-		500V	<u> </u>
5100 10000	512 103				1							500V	

Consult factory for Non-Standard values.

DIELECTRIC CHARACTERISTICS

TEMPERATURE COEFFICIENT: 0 ± 30 ppm /°C, -55 to 150°C

QUALITY FACTOR / DF: Q>1,000 @ 1KHz (C>1,000pF), Typical 10,000 (C<1,000 pF)

INSULATION RESISTANCE: >100 GΩ @ 25°C,WVDC¹;

125°C IR is 10% of 25°C rating

NPO

DIELECTRIC STRENGTH: $500 \text{ V} \le 2.5 \text{ X WVDC}^1 \text{ Min., } 25^{\circ}\text{C}, 50 \text{ mA max}$

> 1000 V ≤ 1.5 X WVDC¹ Min., 25°C, 50 mA max $> 1500 = 1 \text{ X WVDC}^{1} \text{ Min., } 25^{\circ}\text{C}, 50 \text{ mA max}$

TEST PARAMETERS:: 1MHz ±50kHz, 1.0±0.2 VRMS, 25°C

AVAILABLE CAPACITANCE:

Size 0201: 0.2 - 100 pF Size 1111: 0.2 - 1000 pF Size 0402: 0.2 - 33 pF Size 2525: 1.0 - 2700 pF Size 0603: 0.2 - 100 pF Size 3838: 1.0 - 5100 pF

Size 0805: 0.3 - 220 pF

MECHANICAL & ENVIRONMENTAL CHARACTERISTICS

Capacitance change: 5% or

SPECIFICATION TEST PARAMETERS

SOLDERABILITY: Preheat chip to 120°-150°C for 60 sec., dip terminals in rosin flux Solder coverage ≥ 90% of metalized areas

No termination degradation then dip in Sn62 solder @ 240°±5°C for 5±1 sec

RESISTANCE TO No mechanical damage Preheat device to 80°-100°C for 60 sec.

SOLDERING HEAT: Capacitance change: ±2.5% or 0.25pF followed by 150°-180°C for 60 sec. Q>500 I.R. >10 G Ohms Dip in 260°±5°C solder for 10±1 sec. DWV²: 2.5 x WVDC Measure after 24±2 hour cooling period

TERMINAL Termination should not pull off. Linear pull force³ exerted on axial leads soldered to each terminal.

ADHESION: Ceramic should remain undamaged.

PCB DEFLECTION: No mechanical damage. Glass epoxy PCB: 2 mm deflection

0.5pF whichever is greater. Applied voltage: 200% of WVDC1 for capacitors rated at 500 volts DC or less. LIFE TEST: MIL-STD-202, Method 108I

No mechanical damage 100% of WVDC1 for capacitors rated at 1250 volts DC or less.

Capacitance change: ±3.0% or 0.3 pF Temperature: 125°±3°C

Q>500 I.R. >1 G Ohms Test time: 1000+48-0 hours DWV²: 2.5 x WVDC³

THERMAL CYCLE: No mechanical damage. 5 cycles of: 30±3 minutes @ -55°+0/-3°C, Capacitance change: ±2.5% or 0.25pF 2-3 min. @ 25°C, 30±3 min. @ +125°+3/-0°C,

Q>2000 I.R. >10 G Ohms 2-3 min. @ 25°C

DWV2: 2.5 x WVDC1 Measure after 24±2 hour cooling period

HUMIDITY. No mechanical damage. Relative humidity: 90-95% STEADY STATE:

Capacitance change: ±5.0% or 0.50pF max. Temperature: 40°±2°C Q>300 I.R. ≥ 1 G-Ohm Test time: 500 +12/-0 Hours

DWV²: 2.5 x WVDC Measure after 24±2 hour cooling period HUMIDITY. No mechanical damage.

Applied voltage: 1.5 VDC, 50 mA max. Relative humidity: 85±2% Temperature: 40°±2°C Capacitance change: ±5.0% or 0.50pF max. LOW VOLTAGE:

Q>300 I.R. = 1 G-Ohm min. Test time: 240 +12/-0 Hours

DWV²: 2.5 x WVDC¹ Measure after 24±2 hour cooling period

Capacitance change: ±2.5% or 0.25pF Cycle performed for 2 hours in each of three perpendicular directions

Q>1000 I.R. ≥ 10 G-Ohm Frequency range 10Hz to 55 Hz to 10 Hz traversed DWV2: 2.5 x WVDC1 in 1 minute. Harmonic motion amplitude: 1.5mm

¹ - WVDC - Working Voltage DC.

² - DWV - Dielectric Withstanding Voltage.

 3 - 0402 ≥ 2.0lbs, 0603 ≥ 4.0lbs (min).

⁴ - Whichever is less.

No mechanical damage.

AEC-Q200: Qualification required for automotive application - Not available for all series - Call factory for info.



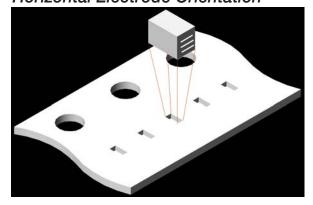
VIBRATION:

MECHANICAL **C**HARACTERISTICS

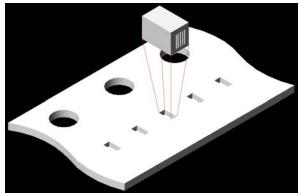
Size	Units	Length	Width	Thickness	End Band
EIA 0201	In	.024 ±.001	.012 ±.001	.012 ±.001	.008 Max.
Metric (0603)	mm	(0.60 ±0.03)	(0.30 ±0.03)	(0.30 ± 0.03)	(0.20 Max.)
EIA 0402	In	.040 ±.004	.020 ±.004	.020 ±.004	.010 ±.006
Metric (1005)	mm	(1.02 ±0.1)	(0.51 ±0.1)	(0.51 ±0.1)	(0.25 ±.15)
EIA 0603	In	.062 ±.006	.032 ±.006	.030 +.005/003	.014 ±.006
Metric (1608)	mm	(1.57 ±0.15)	(0.81 ±0.15)	(0.76 +.1308)	$(0.35 \pm .15)$
EIA 0805	In	.080 ±.008	.050 ±.008	.040 ±.006	.020 ±.010
Metric (2012)	mm	(2.03 ±0.20)	(1.27 ±0.20)	(1.02 ±.15)	$(0.50 \pm .25)$

HORIZONTAL AND VERTICLE ORIENTED CAPACITORS

Horizontal Electrode Orientation



Vertical Electrode Orientation



APPLICATIONS & FEATURES

Size: EIA 0201, 0805, 1111

Performance: SRF's up to 20 GHz, Ultra High Q, Tight tolerance, Ultralow ESR

Termination: Ni/Au, Ni/Sn, Ni/SnPb

Applications: High Frequency Wireless Communications, Portable Wireless Products, Battery Powered

Products

RoHS Compliant

BENIFITS OF USING ORIENTED CAPACITORS

- Consistent Orientation Improved repeatability of production circuits.
- Consistent Orientation More consistent filter performance.
- Vertical Orientation The elimination of parallel frequencies.
- Vertical Orinetation Lower inductance for a given capacitor.
- Horizontal Orientation Lower coupling between adjacent capacitors.

E-SERIES **T**ERMINATIONS AND **L**EADS

CHIP DIMENSIONS

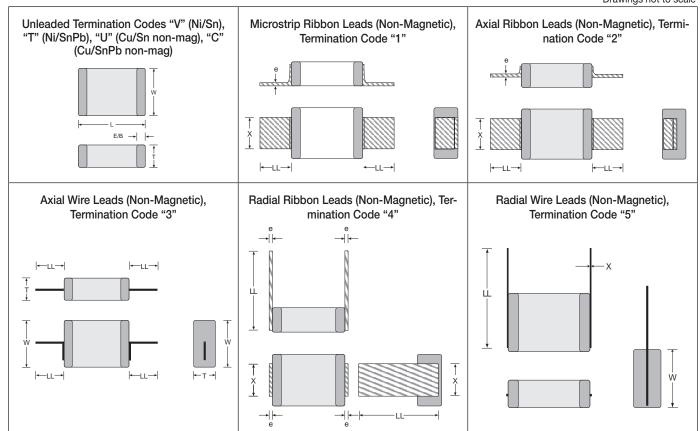
Termination	Size	Units	L	Tol	W	Tol	Т	E/B	Tol
S42	CADE	In	0.110	+.020010	0.110	+/015	0.102 Max.	0.015 Typ.	+/- 0.008
	542E	mm	2.79	+0.51 -0.25	2.79	+/- 0.38	2.59 Max.	0.38 Typ.	+/- 0.20
V,T	V,T S48E	In	0.230	+.025010	0.250	+/015	0.150 Max.	0.025 Typ.	
V,T U,C	340E	mm	5.84	+0.63 -0.25	6.35	+/- 0.38	3.81 Max.	0.63 Typ.	
S58E	CEOE	In	0.380	+.015010	0.380	+/010	0.170 Max.	0.025 Typ.	
	330E	mm	9.65	+0.38 -0.25	9.65	+/- 0.25	4.32 Max.	0.63 Typ.	

For all E-Series Models:

OPERATING TEMP: -55 to +125 °C INSULATION RESISTANCE: >10G Ω @ 25 °C TEMPERATURE COEFFICIENT: 0 ± 30ppm /°C, -55 to 125 °C

DISSIPATION FACTOR (TYP.): < 0.05% @ 1 MHz

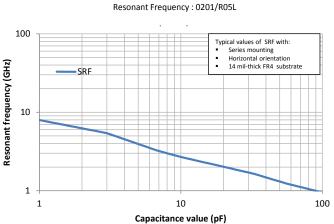
Drawings not to scale

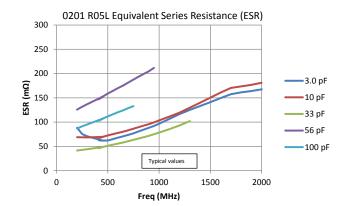


Lead	Size	LL(min)	Χ	Tol	е	e-Tol	
	C40E	0.25	0.093	+/-0.005	0.004	+/- 0.002	
	S42E	6.40	2.36	+/- 0.13	0.102	+/- 0.051	
4	S48E	0.394	0.217	+/- 0.02	0.009	- 0.0019/+ 0.0031	
'	340E	10.0	5.5	+/- 0.50	0.220	- 0.050/+ 0.080	
	S58E	0.748	0.35	+/- 0.02	0.010	- 0.0019/+ 0.0039	
	330E	19.00	8.90	+/- 0.50	0.250	- 0.050/+ 0.100	
	S42E	0.25	0.093	+/-0.005	0.004	+/- 0.002	
		6.40	2.36	+/- 0.13	0.102	+/- 0.051	
2	S48E	0.394	0.217	+/- 0.02	0.009	- 0.0019/+ 0.0031	
~		10.00	5.50	+/- 0.50	0.220	- 0.050/+ 0.080	
	S58E	0.748	0.35	+/- 0.02	0.010	- 0.0019/+ 0.0039	
	330E	19.00	8.90	+/- 0.50	0.25	- 0.050/+ 0.100	
	S42E	0.25					
	342L	6.40					
3	S48E	0.394		0.020in /0) 511) diar	neter wire	
٥	340E	10.00	0.020in (0.511) diameter wire				
	S58E	0.748					
	SUCE	19.00					

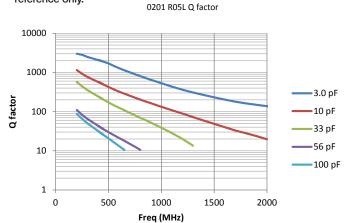
Lead	Size	LL(min)	Χ	Tol	е	e-Tol
	S42E	0.352	0.093	+/-0.005	0.004	+/- 0.002
	342E	8.90	2.36	+/- 0.13	0.102	+/- 0.051
4	CAOE	0.501	0.217	+/- 0.02	0.009	- 0.0019/+ 0.0031
4	S48E	12.70	5.50	+/- 0.50	0.220	- 0.050/+ 0.080
	S58E	0.886	0.35	+/- 0.02	0.010	- 0.0019/+ 0.0039
		22.50	8.90	+/- 0.50	0.25	- 0.050/+ 0.100
	S42E	0.25				
	342E	6.40				
5	S48E	0.394		0.020in (0	\ 511\ diar	notor wiro
5	340E	10.00		0.02011 (0	7.511) ulai	neter wire
	S58E	0.748				
	208E	19.00				

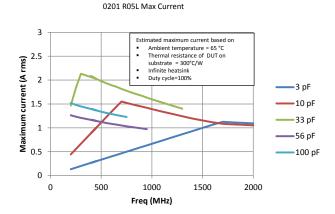
RF CHARACTERISTICS - 0201 R05L SERIES More data at: https://jtisoft.johansontechnology.com



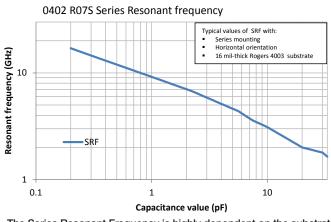


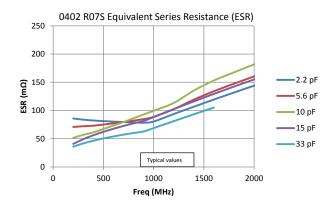
The Series Resonant Frequency is highly dependent on the substrate, pad dimensions, and measurement method. The above chart is for reference only.



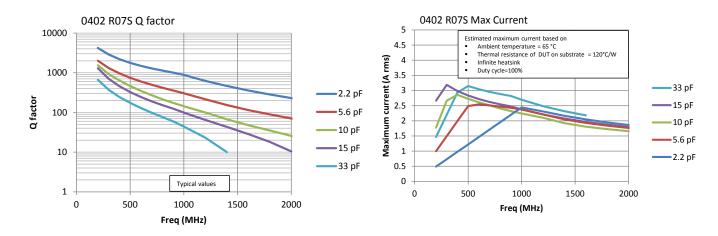


RF CHARACTERISTICS - 0402 R07S SERIES More data at: https://jtisoft.johansontechnology.com

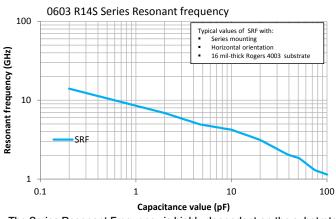


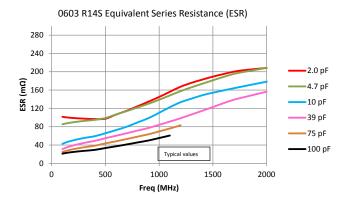


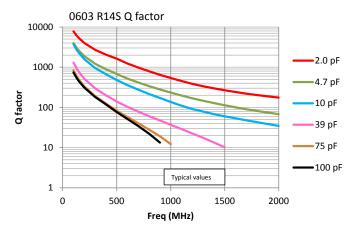
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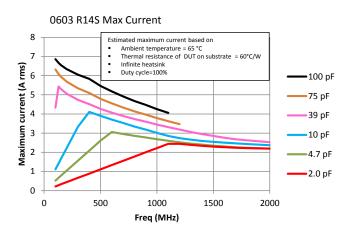


RF CHARACTERISTICS 0603 R14S SERIES More data at: https://jtisoft.johansontechnology.com

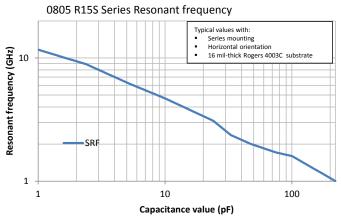


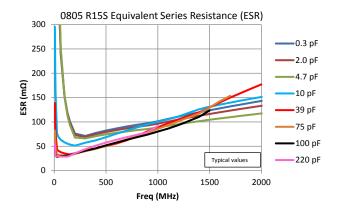


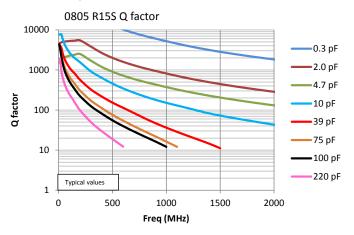




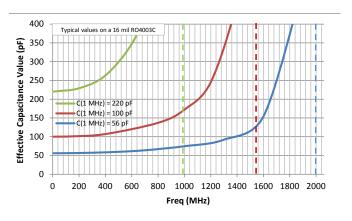
RF CHARACTERISITCS - 0805 R15S SERIES More data at: https://jtisoft.johansontechnology.com

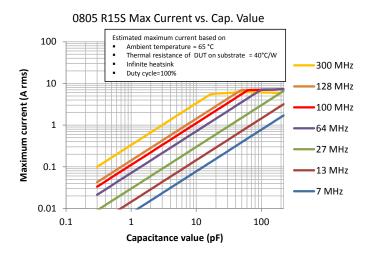


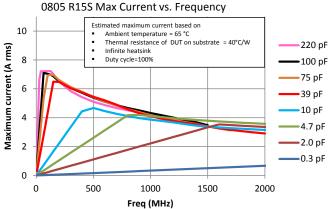




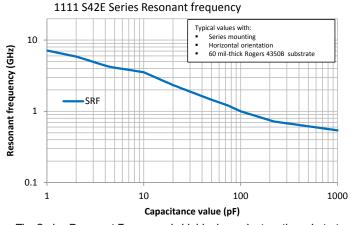


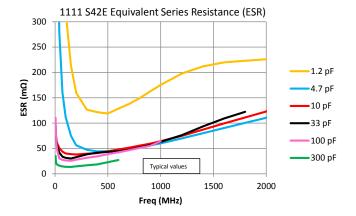


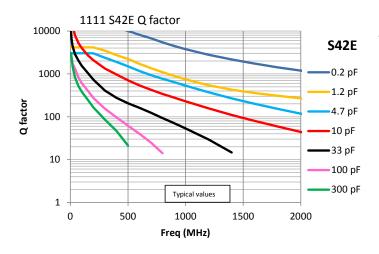


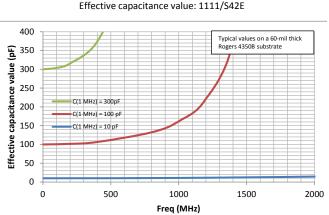


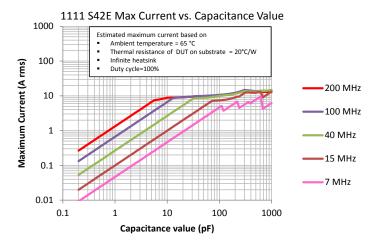
RF CHARACTERISTICS - 1111 S24E SERIES More data at: https://jtisoft.johansontechnology.com

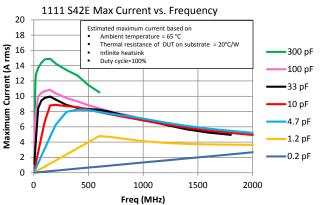




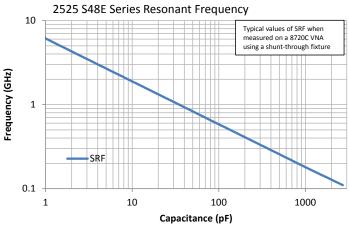


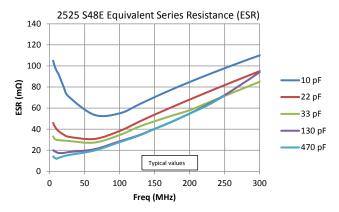


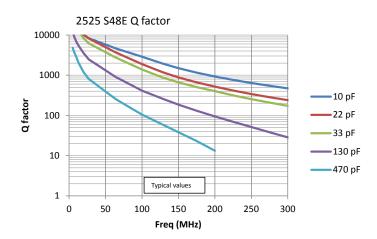


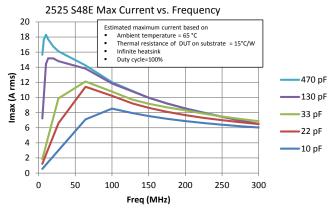


RF CHARACTERISTICS - 2525 S48E SERIES More data at: https://jtisoft.johansontechnology.com

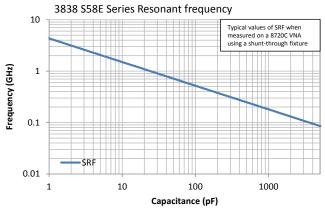




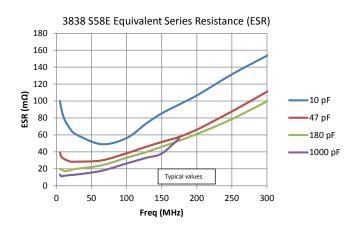


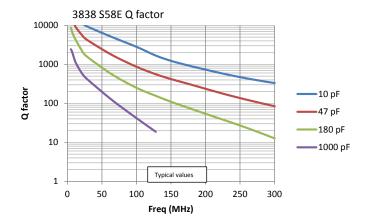


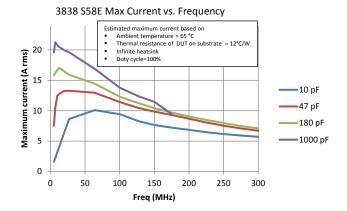
RF CHARACTERISTICS - 3838 S58E SERIES



The Series Resonant Frequency is highly dependent on the substrate, pad dimensions, and measurement method. The above chart is for reference only.







Appendix III Datasheet of 0402 Inductor





Quick Reference Data

Description:

RoHS **Compliant**

The resistors are constructed in a high grade ceramic body (aluminum oxide). Internal metal electrodes are added at each end and connected by a resistive paste that is applied to the top surface of the substrate. The composition of the paste is adjusted to give the approximate resistance required and the value is trimmed to within tolerance by laser cutting of this resistive layer.

The resistive layer is covered with a protective coat. Finally, the two external end terminations are added. For ease of soldering the outer layer of these end terminations is a Tin (lead free) alloy.

Features:

- High reliability and stability
- Reduced size of final equipment
- Lower assembly costs
- Higher component and equipment reliability

Application:

- · Consumer electrical equipment
- EDP, Computer application
- Telecom application

Item		General Sp	ecification				
Series No.	MCWR12	MCWR08	MCWR06	MCWR04			
Size code	1206(3216)	0805(2012)	0603(1608)	0402(1005)			
Resistance Range		1Ω to10MΩ	1% tolerance				
Resistance Tolerance			% /E24				
TCR (ppm/°C) 10MΩ ≥R >10 R≤10Ω	≤ ± 100 -200 to +400						
Max. dissipation @ T _{amb} =70°C	1/4 W	1/8 W	1/10 W	1/16 W			
Max. Operation Voltage (DC or RMS)	200V	200V 150V 75V 50V					
Max. Overload Voltage (DC or RMS)	400V 300V 150V 100V						
Climatic category		55/155/56					

Note:

- 1. Max. Operation Voltage: So called RCWV (Rated Continuous Working Voltage) is determined by RCWV =√Rated Power × Resistance Value or Max. RCWV listed above, whichever is lower.
- 2. The resistance of Jumper is defined <0.05 Ω .

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Protective coat

End termination

Resistive layer Ceramic Substrate Protective coat

	MCWR12	MCWR08	MCWR06	MCWR04
L	3.1 ± 0.1	2 ± 0.1	1.6 ± 0.1	1 ± 0.05
W	1.6 ± 0.1	1.25 ± 0.1	0.8 ± 0.1	0.50 ± 0.05
T	0.6 ± 0.15	0.5 ± 0.15	0.45 ± 0.15	0.35 ± 0.05
Tb	0.45 ± 0.2	0.4 ± 0.2	0.3 ± 0.15	0.25 ± 0.1
Tt	0.5 ± 0.2	0.4 ± 0.2	0.3 ± 0.1	0.2 ± 0.1

Dimensions: Millimetres

Functional Description:

Product characterization

Standard values of nominal resistance is E96 series for resistors with a tolerance of ±1%.

Derating

The power that the resistor can dissipate depends on the operating temperature; see Fig.2

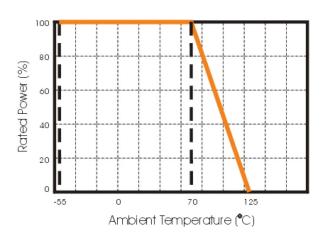


Figure 2 Maximum dissipation in percentage of rated power as a function of the ambient temperature for MCWR12, MCWR08, MCWR06, MCWR04

Mounting

Due to their rectangular shapes and small tolerances, Surface Mountable Resistors are suitable for handling by automatic placement systems.

Chip placement can be on ceramic substrates and printed-circuit boards (PCBs).

Electrical connection to the circuit is by individual soldering condition.

The end terminations guarantee a reliable contact.





Soldering Condition:

The robust construction of chip resistors allows them to be completely immersed in a solder bath of 260°C for 10 seconds. Therefore, it is possible to mount Surface Mount Resistors on one side of a PCB and other discrete components on the reverse (mixed PCBs).

Surface Mount Resistors are tested for solderability at 235°C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds. Typical examples of soldering processes that provide reliable joints without any damage are given in Fig 3.

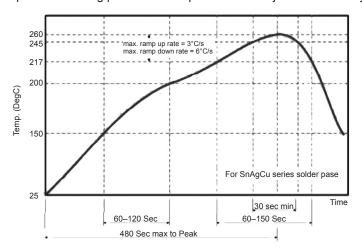


Fig 3. Infrared soldering profile for Chip Resistors

Catalogue Numbers:

The resistors have a catalogue number starting with

MCWR12	X	472	2_	J	Т	L
Size code	Type code	Resistance co	de	Tolerance	Packaging code	Termination
MCWR12 : 1206	X :	±5%, E24: 2 si	0	F: ±1%	T: 7" Reeled taping	code
MCWR08: 0805	$\pm 1\%$, 10Ω to $1M\Omega$	digits followed		P : Jumper	Q: 10" Reeled taping	L = Sn base
MCWR06: 0603	W :	zeros and a bla			G: 13" Reeled taping	(lead free)
MCWR04: 0402	±1%, < 10Ω; >1MΩ	4.7Ω	=4R7_		H: 13" reel 50Kpcs	
	,	10Ω	=100_		only for 0402	
		220Ω	=221_		B : Bulk	
		Jumper	=000_		D: 7" reel 20Kpcs	
		("_" means a b	lank)		only for 0402	
		±1%, E24+E96 digits followed zeros	•		A: 7" reel 15Kpcs only for 0402	
		102Ω	=1020			
		37.4ΚΩ	=3742			

MCWR12, MCWR08, MCWR06:

1. Reeled tape packaging: 8mm width paper taping 5,000pcs per 7" reel, 10kpcs per 10" reel, 20kpcs per 13" reel.

2. Bulk packaging : 5,000pcs per poly-bag

MCWR04:

1. Reeled tape packaging: 8mm width paper taping 10,000pcs per 7" reel, 20,000pcs per 10" reel. 70,000pcs per 13" reel.

: 10,000pcs per poly-bag 2. Bulk packaging





Test and Requirements:

Essentially all tests are carried out according to the schedule of IEC publication 115-8, category LCT/UCT/56 (rated temperature range: Lower Category Temperature, Upper Category Temperature; damp heat, long term, 56 days). The testing also meets the requirements specified by EIA, EIAJ and JIS.

The tests are carried out in accordance with IEC publication 68, "Recommended basic climatic and mechanical robustness testing procedure for electronic components" and under standard atmospheric conditions according to IEC 60068-1, subclause 5.3. Unless otherwise specified, the following value supplied :

Temperature: 15°C to 35°C. Relative humidity: 45% to 75%.

Air pressure: 86kPa to 106 kPa (860 mbar to 1060 mbar). All soldering tests are performed with midly activated flux.

Test	Dresedure / Test Mathed	Requirement	
lest	Procedure / Test Method	Resistor	0Ω
Electrical Characteristics JISC5201-1: 1998 Clause 4.8	- DC resistance values measurement - Temperature Coefficient of Resistance (T.C.R) Natural resistance change per change in degree centigrade. $\frac{R_2-R_1}{R_1(t_2-t_1)}\times 10^6 \; \text{(ppm/°C)} \; \text{t}_{_1} : 20^\circ\text{C}+5^\circ\text{C}/\text{-1} \; ^\circ\text{C}; \; \text{t}_{_2} : -55^\circ\text{C} \; \text{or} \; +155^\circ\text{C} \; \text{R}_{_1} : \text{Resistance} \; \text{at} \; \text{reference} \; \text{temperature} \; (20^\circ\text{C} \; +5^\circ\text{C}/\text{-1} \; ^\circ\text{C}) \; \text{R}_{_2} : \; \text{Resistance} \; \text{at} \; \text{test} \; \text{temperature} \; (-55^\circ\text{C} \; \text{or} \; +155^\circ\text{C})$	Within the specified tolerance Refer to "QUICK REFERENCE DATA"	<50mΩ
Resistance to soldering heat(R.S.H) JISC5201-1:1998 Clause 4.18	Un-mounted chips completely immersed for 10 ±1second in a SAC solder bath at 260°C ±5°C	\pm 1%: ΔR/Rmax. \pm (0.5%+0.05Ω) no visible damage	<50mΩ
Solderability JISC5201-1: 1998 Clause 4.17	Un-mounted chips completely immersed for 10 ±1second in a SAC solder bath at 235°C ±5°C	95% coverage min., good tinning and no visible damage	
Temperature cycling JISC5201-1: 1998 Clause 4.19	30 minutes at -55°C ±3°C, 2-3 minutes at 20°C +5°C -1°C, 30 minutes at +155°C ±3°C, 2-3 minutes at 20°C +5°C -1°C, total 5 continuous cycles	±1%: ΔR/Rmax. ±(0.5%+0.05Ω) No visible damage	<50mΩ
High Temperature Exposure MIL-STD-202 method 108	1,000 +48/-0 hours; without load in a temperature chamber controlled 155 ±3° C	±1%:ΔR/ Rmax.±(1%+0.1Ω) No visible damage	<50mΩ
Bending strength JISC5201-1: 1998 Clause 4.33	Resistors mounted on a 90mm glass epoxy resin PCB(FR4), bending once 3mm for 10sec, 5mm for MCWR04	±1%:ΔR/ Rmax.±(1%+0.05Ω) No visual damaged	<50mΩ
Adhesion JISC5201-1: 1998 Clause 4.32	Pressurizing force: 5N, Test time: 10 ±1sec.	No remarkable damage removal of the terminat	
Short Time Overload (STOL) JISC5201-1: 1998 Clause 4.13	2.5 times RCWV or max. overload voltage, for 5seconds	\pm 1%: ΔR/R max. \pm (1%+0.05Ω) No visible damage	<50mΩ







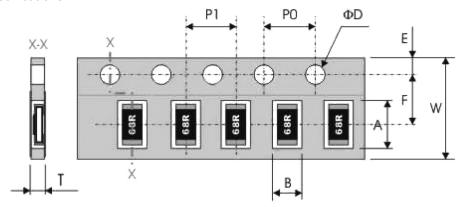
Took	Duncaduus / Took Makkad	Requirement	
Test	Procedure / Test Method	Resistor	0Ω
Load life in Humidity JISC5201-1: 1998 Clause 4.24	1000 +48/-0 hours, loaded with RCWV or Vmax in humidity chamber controller at 40°C± 2°C and 90 to 95% relative humidity, 1.5hours on and 0.5 hours off	\pm 1%: ΔR/R max. \pm (1%+0.1Ω) No visible damage	<50mΩ
Load life (endurance) JISC5201-1: 1998 Clause 4.25	1000 +48/-0 hours, loaded with RCWV or Vmax in chamber controller 70±2°C, 1.5 hours on and 0.5 hours off	\pm 1%: ΔR/R max. \pm (1%+0.1Ω) No visible damage	<50mΩ
Insulation Resistance JISC5201-1: 1998 Clause 4.6	Apply the maximum overload voltage (DC) for 1minute	R≧10GΩ	
Dielectric Withstand Voltage JISC5201-1: 1998 Clause 4.7	Apply the maximum overload voltage (AC) for 1 minute	No breakdown or flasho	over

Test Condition For Jumper (0 Ω)

Item	MCWR12	MCWR08	MCWR06	MCWR04		
Power Rating At 70°C	1/4W	1/8W	1/10W	1/16W		
Resistance	MAX. 50mΩ					
Rated Current	2A	1.5A	1A	1A		
Peak Current	5A	3.5A	3A	2A		
Operating Temperature	-55°C to +155° C					

Packaging:

Paper Tape specifications



Dimensions: Millimetres

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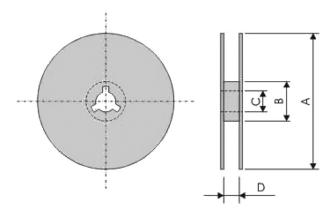




Series No.	Α	В	W	F	E
MCWR12	3.6 ±0.2	2 ±0.2			
MCWR08	2.4 ±0.2	1.65 ±0.2	8 ±0.3	3.5 ±0.2	1.75 ±0.1
MCWR06	1.9 ±0.2	1.1 ±0.2	0 ±0.3		
MCWR04	1.2 ±0.1	0.7 ±0.1			

Series No.	P1	P0	D	Т
MCWR12/WR08	4 ±0.1	4 ±0.1	Ф1.5 +0.1	Max. 1
MCWR06				0.65 ±0.05
MCWR04	2 ±0.1			0.4 ±0.05

7" Reel dimensions:



Symbol	Α	В	С	D
7" reel	Ф178 ±2	Ф60 ±1	13 ±0.2	9 ±0.5
10" reel	Ф254 ±2	Ф100 ±1	13 ±0.2	9 ±0.5
13" reel	Ф330 ±2	Ф100 ±1	13 ±0.2	9 ±0.5

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